

Search Notes

Application/Control No.

10/767,266

Examiner

John D. Lee

Applicant(s)/Patent under
Reexamination

TAMAI ET AL.

Art Unit

2874

SEARCHED

Class	Subclass	Date	Examiner
359	326,328, 332	10/5/2005	JDL
385	15,37	10/5/2005	JDL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
359	326-332	10/6/2005	JDL

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPTO "WEST" Database searched; search strategy on separate sheet.	10/5/2005	JDL
Interference Search (indicated in left column) performed in PGPUBS Database (strategy on separate sheet)	10/6/2005	JDL